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REMARKS

In a telephone interviews with the Examiner between May 29 and June 25, 2003, the Examiner agreed that, upon entering the claim amendments of the current Supplemental Amendment, claims 1-2, 4-5, 7-19, 21, and 23, all the claims pending in the present Application, are allowable over the prior art of record. This Amendment amends claims 19 and 23 and cancels claims 20 and 22 without prejudice or disclaimer. Claim 19 incorporates allowable subject matter from claim 20, which places claim 19 in condition for immediate allowance. The amendments to claim 23 also place this claim in condition for immediate allowance.

It is noted that the claim amendments are made only for more particularly pointing out the invention, and not for distinguishing the invention over the prior art, narrowing the claims or for any statutory requirements of patentability. Further, Applicant specifically states that no amendment to any claim herein should be construed as a disclaimer of any interest in or right to an equivalent of any element or feature of the amended claim.

FORMAL MATTERS AND CONCLUSION

In view of the foregoing, Applicant submits that claims 1-2, 4-5, 7-19, 21, and 23, all the claims presently pending in the application, are patentably distinct over the prior art of record and are in condition for allowance. The Examiner is respectfully requested to pass the above application to issue at the earliest possible time.

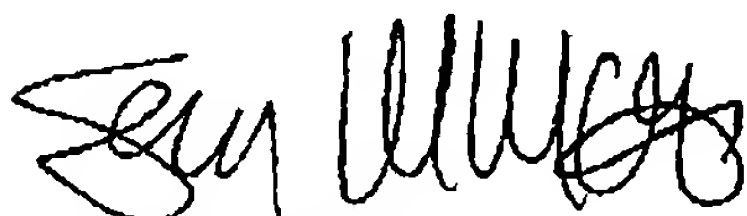
Should the Examiner find the application to be other than in condition for allowance, the Examiner is requested to contact the undersigned at the local telephone number listed below to discuss any other changes deemed necessary in a telephonic or personal interview.

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Please charge any deficiencies in fees and credit any overpayment of fees to Attorney's
Deposit Account No. 50-0481.

Respectfully submitted,



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CERTIFICATION OF FACSIMILE TRANSMISSION

I hereby certify that I am filing this Supplemental Amendment by facsimile with the United States Patent and Trademark Office to Examiner Jaydi A. Aguirrechea Group Art Unit 2834 at fax number (703) 746-8597 this 18th day of July, 2003.

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VERSION WITH MARKINGS TO SHOW CHANGES MADE

IN THE CLAIMS:

Please cancel claims 20 and 22 without prejudice or disclaimer.

Please amend the claims to read as follows:

19. (Amended) A surface acoustic wave filter, comprising:

a plurality of comb electrode patterns formed on a first surface of a chip substrate, wherein the comb electrode patterns serve as an input signal electrode terminal, an output signal electrode terminal, and a ground electrode terminal; and

a coating film of a conductive material, wherein the coating film covers at least part of a second surface of the chip substrate and wherein the coating film is connected to the ground electrode terminal on the first surface of the chip substrate, and

wherein the coating film is connected to the ground electrode terminal by an extension of the coating film conductive material from the coating film on the second surface to the ground electrode terminal on the first surface.

23. (Amended) A surface acoustic wave filter, comprising:

a plurality of pairs of comb electrode patterns formed on an upper surface of a chip substrate comprising a piezoelectric material, comprising a first pattern formed on the upper surface of the chip substrate so as to extend from part of at least one member of each of the pairs of comb electrode patterns, and

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a second pattern formed on the upper surface of the chip substrate so as to oppose the first pattern at a predetermined gap.

wherein said second pattern includes a first line extension pattern having a line width narrower than the width of said second pattern; and

a dummy electrode pattern formed on the upper surface of the chip substrate [so as to be adjacent and connected to the comb electrode patterns] that includes a second line extension pattern opposing said first line extension pattern, said second line extension pattern having a line width narrower than the width of said second pattern.

wherein a width of a gap between said first and said second line extension patterns is narrower than said predetermined gap between said first and said second patterns.